

January 1990 Revised December 1998

74ACT899

9-Bit Latchable Transceiver with Parity Generator/Checker

General Description

The ACT899 is a 9-bit to 9-bit parity transceiver with transparent latches. The device can operate as a feed-through transceiver or it can generate/check parity from the 8-bit data busses in either direction. The ACT899 features independent latch enables for the A-to-B direction and the B-to-A direction, a select pin for ODD/EVEN parity, and separate error signal output pins for checking parity.

Features

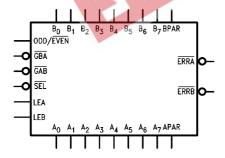
- Latchable transceiver with output sink of 24 mA
- Option to select generate parity and check or "feed-through" data/parity in directions A-to-B or B-to-A
- Independent latch enable for A-to-B and B-to-A directions
- Select pin for ODD/EVEN parity
- ERRA and ERRB output pins for parity checking
- Ability to simultaneously generate and check parity
- May be used in system applications in place of the 280
- May be used in system applications in place of the 657 and 373 (no need to change T/R to check parity)

Ordering Code:

Order Number	Package Number		11 1		Package Description
74ACT899QC	V28A	28-Lead Plas	stic Lead	d Chip C	Carrier (PLCC), JEDEC MO-047, 0.450" Square

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

Logic Symbol



Connection Diagram

Pin Assignment for PCC A7 A6 A5 A4 A3 A2 A1 11 10 9 8 7 6 5 APAR 12 GBA 13 GND 14 ERRB 15 SEL 16 LEB 17 BPAR 18 19 20 21 22 33 24 25 B7 B6 B5 B4 B3 B2 B1

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Pin Descriptions

Pin Names	Description
A ₀ -A ₇	A Bus Data Inputs/Data Outputs
B ₀ -B ₇	B Bus Data Inputs/Data Outputs
APAR, BPAR	A and B Bus Parity Inputs
ODD/EVEN	ODD/EVEN Parity Select, Active LOW for EVEN Parity
GBA, GAB	Output Enables for A or B Bus, Active LOW
SEL	Select Pin for Feed-Through or Generate Mode, LOW for Generate Mode
LEA, LEB	Latch Enables for A and B Latches, HIGH for Transparent Mode
ERRA, ERRB	Error Signals for Checking Generated Parity with Parity In, LOW if Error Occurs

Functional Description

The ACT899 has three principal modes of operation which are outlined below. These modes apply to both the A-to-B and B-to-A directions.

- Bus A (B) communicates to Bus B (A), parity is generated and passed on to the B (A) Bus as BPAR (APAR). If LEB (LEA) is HIGH and the Mode Select $(\overline{\text{SEL}})$ is LOW, the parity generated from B[0:7] (A[0:7]) can be checked and monitored by $\overline{\text{ERRB}}$ (ERRA).
- Bus A (B) communicates to Bus B (A) in a feed-through mode if SEL is HIGH. Parity is still generated and checked as ERRA and ERRB in the feed-through mode (can be used as an interrupt to signal a data/parity bit error to the CPU).
- Independent Latch Enables (LEA and LEB) allow other permutations of generating/checking (see Function Table).

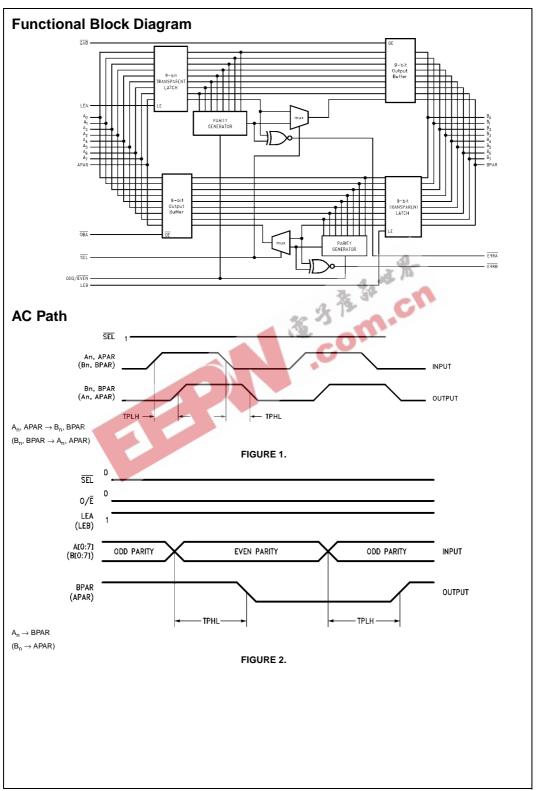
Function Table

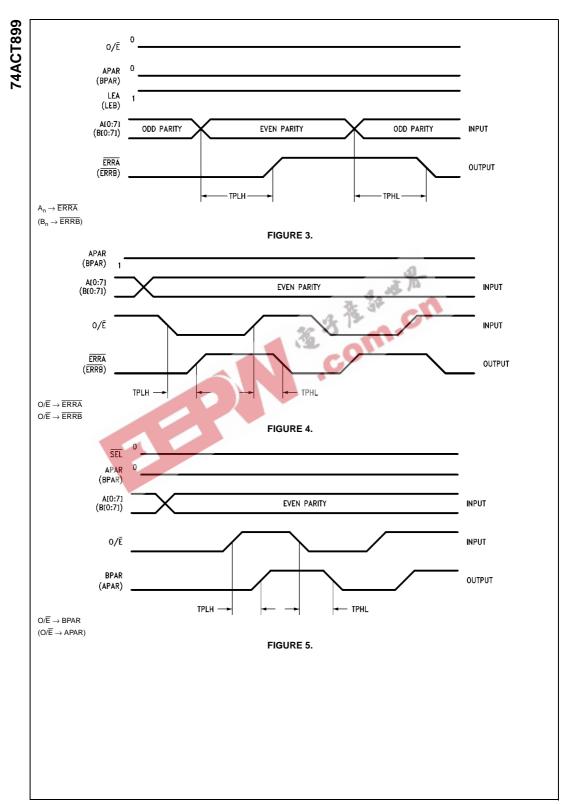
						·							
un	cti	ion ⁻	Tabl	е		A A R							
	Inputs					Operation							
G	AB	GBA	SEL	LEA	LEB	3 73 6							
ŀ	Η	Н	Х	Х	Х	Busses A and B are 3-STATE.							
ŀ	Η	L	L	L	Н	Generates parity from B[0:7] based on O/E (Note 1). Generated parity → APAR. Generated parity checked against BPAR and output as ERRB.							
ŀ	H	L	L	Н	H	Generates parity from B[0:7] based on O/Ē. Generated parity → APAR. Generated parity checked against BPAR and output as ERRB. Generated parity also fed back through the A latch for generate/check as ERRĀ.							
ŀ	Τ	L	L	Х	T	Generates parity from B latch data based on O/E. Generated parity → APAR. Generated parity checked against latched BPAR and output as ERRB.							
ŀ	Τ	L	Н	Х	Н	BPAR/B[0:7] → APAR/A0:7] Feed-through mode. Generated parity checked against BPAR and output as ERRB.							
ŀ	Η	L	Н	Н	Н	$BPAR/B[0:7] \to APAR/A[0:7]$							
						Feed-through mode. Generated parity checked against BPAR and output as <u>ERRB</u> . Generated parity also fed back through the A latch for generate/check as <u>ERRA</u> .							
I	L	Н	L	Н	L	Generates parity for A[0:7] based on O/\overline{E} . Generated parity \to BPAR. Generated parity checked against APAR and output as \overline{ERRA} .							
ı	L	Н	L	Н	Н	Generates parity from A[0:7] based on O/\overline{E} . Generated parity \rightarrow BPAR. Generated parity checked against APAR and output as \overline{ERRA} . Generated parity also fed back through the B latch for generate/check as \overline{ERRB} .							
ı	L	Н	L	L	Х	Generates parity from A latch data based on O/\overline{E} . Generated parity \to BPAR. Generated parity checked against latched APAR and output as \overline{ERRA} .							
I	L	Н	Н	Н	L	$APAR/A[0:7] \to BPAR/B[0:7]$							
						Feed-through mode. Generated parity checked against APAR and output as ERRA.							
I	L	Н	Н	Н	Н	$APAR/A[0:7] \to BPAR/B[0:7]$							
						Feed-through mode. Generated parity checked against APAR and output as ERRA. Generated parity also fed back through the B latch for generate/check as ERRB.							

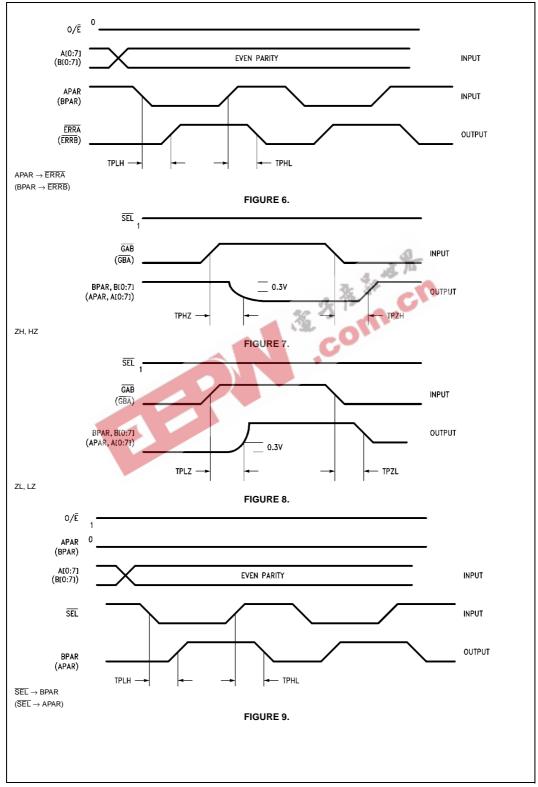
H = HIGH Voltage Leve

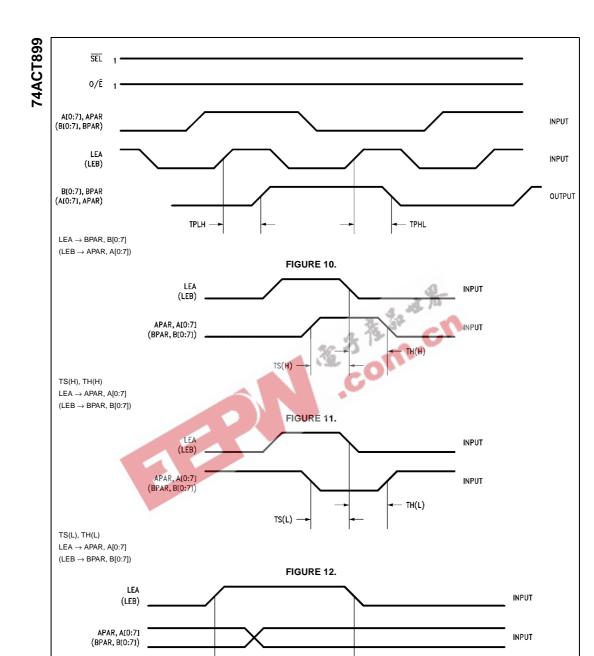
Note 1: $O/\overline{E} = ODD/\overline{EVEN}$

L = LOW Voltage Level X = Immaterial









BPAR, A[0:7] (APAR, B[0:7])

tw →

FIGURE 13.

OUTPUT

Absolute Maximum Ratings(Note 2)

Supply Voltage (V_{CC}) -0.5V to +7.0V

DC Input Diode Current (I_{IK})

 $\begin{array}{ccc} V_{I}=-0.5 V & -20 \text{ mA} \\ V_{I}=V_{CC}+0.5 V & +20 \text{ mA} \\ \text{DC Input Voltage (V_{I})} & -0.5 V \text{ to V}_{CC}+0.5 V \end{array}$

DC Output Diode Current (I_{OK})

 $\begin{aligned} \text{V}_{\text{O}} &= -0.5 \text{V} & -20 \text{ mA} \\ \text{V}_{\text{O}} &= \text{V}_{\text{CC}} + 0.5 \text{V} & +20 \text{ mA} \\ \text{DC Output Voltage (V}_{\text{O}}) & -0.5 \text{V to V}_{\text{CC}} + 0.5 \text{V} \end{aligned}$

DC Output Source

or Sink Current (I_O) ± 50 mA

DC V_{CC} or Ground Current

per Output Pin (I_{CC} or I_{GND}) ± 50 mA Storage Temperature (T_{STG}) -65° C to $+150^{\circ}$ C

DC Latch-Up Source or

Sink Current $\pm 300 \text{ mA}$ Junction Temperature (T_J) 140°C

Recommended Operating Conditions

 V_{IN} from 0.8V to 2.0V

V_{CC} @ 4.5V, 5.5V

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	v _{cc}			$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	Units	Conditions
		(V)	Тур	Gua	aranteed Limits		
V _{IH}	Minimum HIGH Level	4.5	1.5	2.0	2.0	V	$V_{OUT} = 0.1V$
	Input Voltage	5.5	1.5	2.0	2.0		or V _{CC} – 0.1V
V _{IL}	Maximum LOW Level	4.5	1.5	0.8	0.8	V	$V_{OUT} = 0.1V$
	Input Voltage	5.5	1.5	0.8	0.8		or V _{CC} – 0.1V
V _{OH}	Minimum HIGH Level	4.5	4.49	4.4	4.4	V	$I_{OUT} = -50 \mu A$
	Output Voltage	5.5	5.49	5.4	5.4		
							$V_{IN} = V_{IL}$ or V_{IH}
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA} \text{ (Note 3)}$
V _{OL}	Maximum LOW Level	4.5	0.001	0.1	0.1	V	$I_{OUT} = 50 \mu A$
	Output Voltage	5.5	0.001	0.1	0.1		
							$V_{IN} = V_{IL}$ or V_{IH}
		4.5		0.36	0.44	V	$I_{OL} = 24 \text{ mA}$
		5.5		0.36	0.44		I _{OL} = 24 mA (Note 3)
I _{IN}	Maximum Input	5.5		±0.1	±1.0	μА	$V_I = V_{CC}$, GND
	Leakage Current						
I _{OZ}	Maximum 3-STATE	5.5		±0.5	±5.0	μΑ	$V_I = V_{IL}, V_{IH}$
	Leakage Current						$V_O = V_{CC}$, GND
I _{CCT}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	$V_{I} = V_{CC} - 2.1V$
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 4)	5.5			-75	mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent	5.5		8.0	80.0	μΑ	$V_{IN} = V_{CC}$
	Supply Current						or GND

Note 3: Maximum of 9 outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics

		V _{CC}		$T_A = +25^{\circ}C$		T _A = -40°0	C to +85°C		
Symbol	Parameter	(V)	$C_L = 50 \text{ pF}$			$C_L = 50 \text{ pF}$		Units	Fig. No.
		(Note 5)	Min	Тур	Max	Min	Max		
t _{PLH}	Propagation Delay	5.0	2.5	7.5	11.5	2.5	12.0	ns	Figure 1
t _{PHL}	A_n , B_n to B_n , A_n								
t _{PLH}	Propagation Delay	5.0	1.5	6.0	8.5	1.5	9.0	ns	Figure 1
t _{PHL}	APAR, BPAR to BPAR, APAR								
t _{PLH}	Propagation Delay	5.0	2.5	8.5	12.0	2.5	12.5	ns	Figure 2
t _{PHL}	A _n , B _n to BPAR, APAR								
t _{PLH}	Propagation Delay	5.0	2.0	8.0	11.5	2.0	12.0	ns	Figure 3
t _{PHL}	A _n , B _n to ERRA, ERRB								
t _{PLH}	Propagation Delay	5.0	2.0	8.0	11.5	2.0	12.0	ns	Figure 4
t _{PHL}	ODD/EVEN to ERRA, ERRB								
t _{PLH}	Propagation Delay	5.0	2.5	8.0	11.5	2.5	12.0	ns	Figure 5
t _{PHL}	ODD/EVEN to APAR, BPAR								
t _{PLH}	Propagation Delay	5.0	1.5	7.5	10.5	1.5	11.5	ns	Figure 6
t _{PHL}	APAR, BPAR to ERRA, ERRB					- 95			
t _{PLH}	Propagation Delay	5.0	1.5	6.5	9.0	1.5	9.5	ns	Figure 9
t _{PHL}	SEL to APAR, BPAR				3c 31				
t _{PLH}	Propagation Delay	5.0	2.5	7.0	10.5	2.5	11.0	ns	Figure 10
t _{PHL}	LEB to A _n , B _n			26	- 10	100			Figure 11
t _{PLH}	Propagation Delay	5.0	2.0	8.0	11.5	2.0	12.0	ns	Figure 10
t _{PHL}	LEA to APAR, BPAR								Figure 11
t _{PLH}	Propagation Delay	5.0	2.5	8.0	11.5	2.5	12.0	ns	Figure 12
t _{PHL}	LEA, LEB to ERRA, ERRB								
t _{PZH}	Output Enable Time	5.0	2.5	7.0	10.5	2.5	11.0	ns	Figure 7
t _{PZL}	GBA or GAB to A _n , B _n								Figure 8
t _{PZH}	Output Enable Time	5.0	1.5	6.0	9.0	1.5	9.5	ns	Figure 7
t _{PZL}	GBA or GAB to BPAR or APAR								Figure 8
t _{PHZ}	Output Disable Time	5.0	1.5	6.5	9.5	1.5	9.5	ns	Figure 7
t _{PHL}	GBA or GAB to A _n , B _n								Figure 8
t _{PHZ}	Output Disable Time	5.0	1.5	6.5	9.5	1.5	9.5	ns	Figure 7
t _{PLZ}	GBA or GAB to BPAR, APAR								Figure 8

Note 5: Voltage Range 5.0 is 5.0V ± 0.5V.

AC Operating Requirements

Symbol	Parameter	v _{cc} (v)	$T_A = +25$ °C $C_L = 50 \text{ pF}$	$T_A = -40$ °C to $+85$ °C $C_L = 50$ pF	Units	Fig. No.
		(Note 6)	Guarantee	d Minimum		
t _S	Setup Time, HIGH or LOW	5.0	3.0	3.0	ns	Figure 11
	A _n , B _n , PAR to LEA, LEB					Figure 12
t _H	Hold Time, HIGH or LOW	5.0	1.5	1.5	ns	Figure 11
	A _n , B _n , PAR to LEA, LEB					Figure 12
t _W	Pulse Width for LEB, LEA	5.0	4.0	4.0	ns	Figure 13

Note 6: Voltage Range $5.0 = 5.0 \text{V} \pm 0.5 \text{V}$.

Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = 5.0V
C _{PD}	Power Dissipation Capacitance	210	pF	V _{CC} = 5.0V

Physical Dimensions inches (millimeters) unless otherwise noted 0.450 +0.006 -0.000 [11.43] +0.15 -0.00 √45° X 0.045 PIN #1 IDENT 0.017±0.004 _{TYP} 0.029±0.003_{TYP} [0.43±0.10] [0.74±0.08] 19 0.410±0.020 TYP [10.41±0.51] 0.050 TYP SEATING PLANE 0.020 MIN TYP [1.27] __0.300 [0.51] 0.105±0.015 [2.67±0.38] [7.62] 45° X [1.14] 0.165-0.180 [4.19-4.57] 0.490±0.005

28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450" Square Package Number V28A

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12.45±0.13]

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